
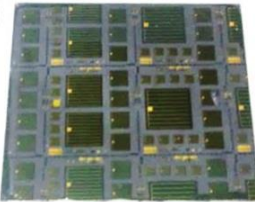
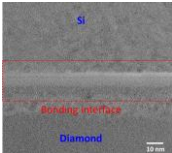


## Requests for Collaboration

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| <p><b>Name: Naoteru Shigekawa</b><br/> <b>Current position: Professor</b><br/> <b>E-mail address: shigekawa@eng.osaka-cu.ac.jp</b></p>   |  |
| <p><b>Research Interests</b></p> <ul style="list-style-type: none"> <li>● Heterogeneous integration of foreign materials using low-temperature direct bonding technologies.</li> <li>● Fabrication of novel green devices using heterogeneously-integrated materials.</li> <li>● Characterization of bonding interfaces.</li> </ul>  |   |
| <p><b>Scientific and Technological Achievements</b></p>  |   |
| <p><b>(1) InGaP/GaAs/Si hybrid tandem (triple-junction) solar cells are fabricated by bonding III-V (InGaP/GaAs) epitaxial substrates to Si-based single-junction cell structures and applying device process. Conversion efficiencies of &gt;26% are observed. Lower parasitic resistances and higher efficiencies are achieved by inserting indium-tin-oxide (ITO) films between III-V layers and Si.</b></p> <div style="display: flex; justify-content: space-around; align-items: flex-start;"> <div data-bbox="188 882 906 1137" style="width: 45%;"> <p><b>(2) Single crystal diamonds are successfully bonded to Si substrates. Bonding interfaces show tolerance against high-temperature (1000 °C) irrespective of large difference in coefficients of thermal expansion. The mechanism of the tolerance of interfaces is under investigation.</b></p> </div> <div data-bbox="922 842 1187 1043" style="width: 25%;">  <p>A Photo of triple-junction cells.</p> </div> <div data-bbox="1203 842 1385 994" style="width: 25%;">  <p>A TEM image of a diamond/Si interface.</p> </div> </div>  |   |
| <p><b>Other achievements are shown on web. (<a href="http://shigekawa-ocu.jp">http://shigekawa-ocu.jp</a>)</b></p>   |   |
| <p><b>Research Themes for Possible Collaboration</b></p>   |   |
| <ul style="list-style-type: none"> <li>● Fabrication of junctions of foreign materials (semiconductor, metal, insulator, and so on) that are fabricated using direct bonding technologies</li> <li>● Characterization and device application of such heterogeneous-integration-based junctions and interfaces.</li> </ul>  |   |
| <p><b>A List of 5 Key Publications</b></p>   |   |
| <ul style="list-style-type: none"> <li>• <u>Naoteru Shigekawa</u>, Tomoya Hara, Tomoki Ogawa, Jianbo Liang, Takefumi Kamioka, Kenji Araki, and Masafumi Yamaguchi, "GaAs/Indium Tin Oxide/Si Bonding Junctions for III-V-on-Si Hybrid Multijunction Cells With Low Series Resistance", IEEE J. Photovolt. <b>8</b> (3), pp. 879-886 (2018) (8 pages) (DOI: 10.1109/JPHOTOV.2018.2802203).</li> <li>• <u>Naoteru Shigekawa</u>, Sae Shimizu, Jianbo Liang, Masato Shingo, Kenji Shiojima, and Manabu Arai, "Transport characteristics of minority electrons across surface-activated-bonding based p-Si/n-4H-SiC heterointerfaces", Jpn. J. Appl. Phys. <b>57</b>, 02BE04 (2018) (5 pages) (DOI: 10.7567/JJAP.57.02BE04).</li> <li>• Jianbo Liang, Katsuya Furuna, Moeko Matsubara, Marwan Dhamrin, Yoshitaka Nishio, and <u>Naoteru Shigekawa</u>, "Aluminum Foil/Si Direct Bonding as Prototypes of Ultra-Thick Metal Contacts in Devices", ECS J. Solid State Sci. Technol., <b>6</b> (9) pp. P626-P632 (2017) (7 pages) (DOI: 10.1149/2.0251709jss).</li> <li>• Jianbo Liang, Satoshi Masuya, Makoto Kasu, and <u>Naoteru Shigekawa</u>, "Realization of direct bonding of single crystal diamond and Si substrates", Appl. Phys. Lett. <b>110</b>, 111603 (2017) (4 pages) (DOI: 10.1063/1.4978666).</li> <li>• J. Liang, S. Nishida, M. Arai, and <u>N. Shigekawa</u>, "Improved electrical properties of n-n and p-n Si/SiC junctions with thermal annealing treatment," J. Appl. Phys. <b>120</b>, 034504 (2016) (7 pages) (DOI: 10.1063/1.4959072).</li> </ul> |   |